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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
6h	AW	D.F. WILLIAMS AND W.H. SCHMITT ED.: "Chemistry and technology of the cosmetics and toiletries industry, 2nd edition, 1996", BLACKIE ACADEMIC AND PROFESSIONAL (Pgs. 93-97)							
94	AX	R.C. PEPE ET AL. ED.: "International cosmetic ingredient dictionary and handbook, 9 <sup>th</sup> ed., 2002, vol. 2°, THE COSMETIC, TOILETRY AND FRAGRANCE ASSOCIATION, USA (Pg. 1578)							
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